

Search Notes

Application/Control No.

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Examiner

Su C. Kim

Applicant(s)/Patent under
Reexamination

YU ET AL.

Art Unit

2823

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
word search	5/17/2005	SK
NPL document search on IEEE reference	5/17/2005	SK